

April 1988 Revised August 1999

74F280

9-Bit Parity Generator/Checker

General Description

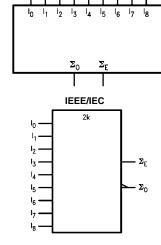
The F280 is a high-speed parity generator/checker that accepts nine bits of input data and detects whether an even or an odd number of these inputs is HIGH. If an even number of inputs is HIGH, the Sum Even output is HIGH. If an odd number is HIGH, the Sum Even output is LOW. The Sum Odd output is the complement of the Sum Even output.

Ordering Code:

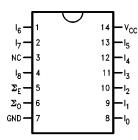
Order Number	Package Number	Package Description
74F280SC	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow
74F280SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F280PC	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



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DS009512

Unit Loading/Fan Out

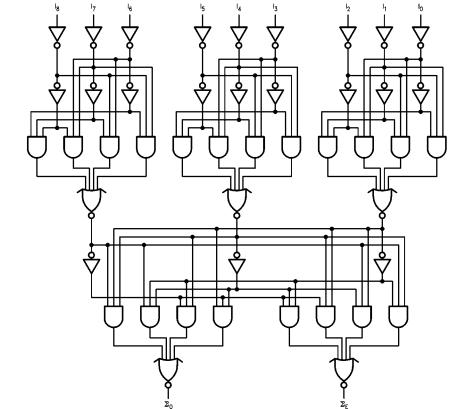
Pin Names	Description	U.L.	Input I _{IH} /I _{IL}		
riii Nailles	Description	HIGH/LOW	Output I _{OH} /I _{OL}		
I ₀ -I ₈	Data Inputs	1.0/1.0	20 μA/-0.6 mA		
Σ_{O}	Odd Parity Output	50/33.3	−1 mA/20 mA		
Σ_{E}	Even Parity Output	50/33.3	−1 mA/20 mA		

Truth Table

Number of	Outputs					
HIGH Inputs I ₀ –I ₈	∑ Even	Σ Odd				
0, 2, 4, 6, 8	Н	L				
1, 3, 5, 7, 9	L	Н				

H = HIGH Voltage Level L = LOW Voltage Level

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 1)

Recommended Operating Conditions

 $\begin{array}{ll} \mbox{Storage Temperature} & -65\mbox{°C to } +150\mbox{°C} \\ \mbox{Ambient Temperature under Bias} & -55\mbox{°C to } +125\mbox{°C} \\ \end{array}$

Junction Temperature under Bias -55°C to +150°C

 $\begin{array}{lll} \text{V}_{\text{CC}} \text{ Pin Potential to Ground Pin} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Voltage (Note 2)} & -0.5 \text{V to } +7.0 \text{V} \\ \text{Input Current (Note 2)} & -30 \text{ mA to } +5.0 \text{ mA} \\ \end{array}$

Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{ll} \mbox{Standard Output} & -0.5\mbox{V to V}_{\mbox{CC}} \\ \mbox{3-STATE Output} & -0.5\mbox{V to +5.5\mbox{V}} \end{array}$

Current Applied to Output

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

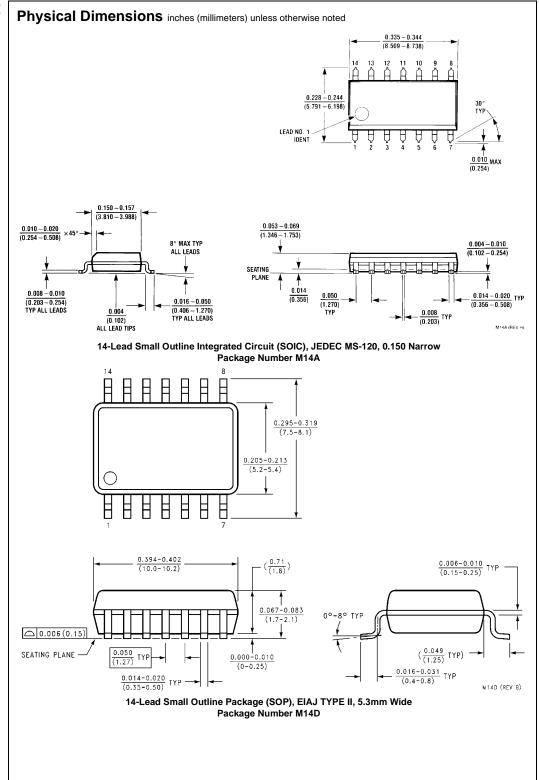
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

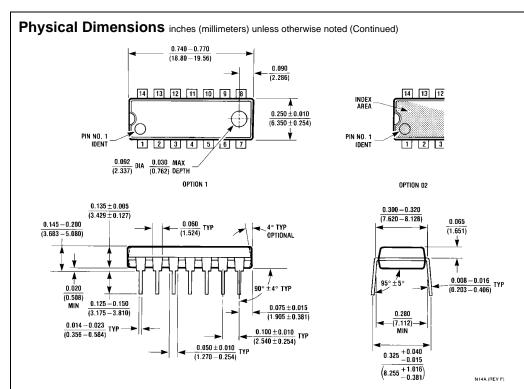
DC Electrical Characteristics

Symbol	Parameter		Min	Тур	Max	Units	v _{cc}	Conditions	
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage				8.0	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH	10% V _{CC}	2.5			V	Min	I _{OH} = -1 mA	
	Voltage	$5\% V_{CC}$	2.7			V		$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW	10% V _{CC}			0.5	V	Min	L- = 20 mΛ	
	Voltage							I _{OL} = 20 mA	
I _{IH}	Input HIGH				5.0	μА	Max	V _{IN} = 2.7V	
	Current				3.0	μΛ	IVIAX		
I _{BVI}	Input HIGH Current				7.0	μА	Max	V _{IN} = 7.0V	
	Breakdown Test							V _{IN} = 7.0 V	
I _{CEX}	Output HIGH			-	50	μА	Max	V _{OUT} = V _{CC}	
	Leakage Current								
V _{ID}	Input Leakage		4.75			V	0.0	$I_{ID} = 1.9 \mu A$	
	Test		4.73					All Other Pins Grounded	
I _{OD}	Output Leakage				3.75	μА	0.0	V _{IOD} = 150 mV	
	Circuit Current							All Other Pins Grounded	
I _{IL}	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V	
los	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V	
I _{CCH}	Power Supply Current			25	38	mA	Max	V _O = HIGH	

AC Electrical Characteristics

	Parameter	$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = 5.0V$ $C_{L} = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = 5.0V$ $C_L = 50$ pF		Units
Symbol									
t _{PLH}	Propagation Delay	6.5	10.0	15.0	6.5	20.0	6.5	16.0	no
t _{PHL}	I_n to Σ_E	6.5	11.0	16.0	6.5	21.0	6.5	17.0	ns
t _{PLH}	Propagation Delay	6.0	10.0	15.0	5.0	20.0	6.0	16.0	no
t _{PHI}	I_n to Σ_O	6.5	11.0	16.0	6.5	21.0	6.5	17.0	ns





14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N14A

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